

Achieving Remarkable Amplification of Energy-Storage Density in Two-Step Sintered $\text{NaNbO}_3\text{--SrTiO}_3$ Antiferroelectric Capacitors through Dual Adjustment of Local Heterogeneity and Grain Scale

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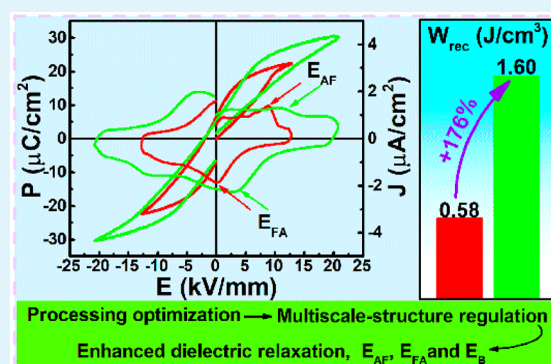
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ABSTRACT: Antiferroelectric (AFE) materials exhibit outstanding advantages against linear or ferroelectric (FE) dielectrics in high-performance energy-storage capacitors. However, their energy-storage performances are usually restricted by both extremely large hysteresis and insufficiently high driving field of the AFE-FE phase transition, which has been a longstanding issue to be overcome in the community. In this work, we report a two-step sintered $0.83\text{NaNbO}_3\text{--}0.17\text{SrTiO}_3$ (NN-ST) lead-free relaxor AFE R-phase ceramic with high relative density of $\geq 95\%$ and large spans of average grain sizes from 1.2 to $8.2\ \mu\text{m}$, strikingly achieving a giant amplification of recoverable energy-storage density (W_{rec}) by 176%. Analyses of permittivity-temperature curves, Raman spectrum and microstructure demonstrate that remarkably enhanced W_{rec} values should be ascribed to the dual adjustment of local heterogeneity (nanoscale) and grain scale (microscale), resulting in the enhanced threshold field strength for dielectric breakdown and the increased critical electric fields for the AFE-FE phase transition. A high $W_{\text{rec}} \approx 1.60\ \text{J}/\text{cm}^3$, a fast discharging rate $t_{0.9} \approx 520\ \text{ns}$, large current density $\sim 788\ \text{A}/\text{cm}^2$, and large power density $\sim 55\ \text{MW}/\text{cm}^3$ are achieved at room temperature in the NN-ST ceramic sample with an average grain size of $\sim 1.2\ \mu\text{m}$. These results suggest that the multiscale structure regulation should be an efficient way for achieving enhanced energy-storage properties in NN-ST relaxor AFE ceramics through a two-step sintering technique.

KEYWORDS: lead-free, relaxor antiferroelectric, energy storage, NaNbO_3 , two-step sintering



1. INTRODUCTION

Antiferroelectric (AFE) materials exhibit unique double polarization versus electric field (P - E) hysteresis loops as a result of electric field induced reversible AFE-ferroelectric (FE) phase transition, clearly showing large advantages in energy-storage capacitors because of relatively large polarization difference ΔP ($= P_{\text{max}} - P_r$, where P_{max} is maximum polarization and P_r is remanent polarization), compared with linear dielectrics or FEs.^{1–5} It has been found that the adjustment of the critical electric fields for phase transition and the improvement of the breakdown strength (E_B) should be crucial for realizing excellent energy storage properties of an AFE ceramic.^{6–9} Giant recoverable energy-storage density (W_{rec}) of 3–11 J/cm^3 was reported in PbZrO_3 -based AFE ceramics.^{8–11} However, considering the detrimental effect of lead oxide on the environment and human health, more and more attention has been paid to lead-free AFE ceramics in recent years.^{12–17}

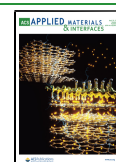
Because of the existence of multiple AFE phases with changing temperature, NaNbO_3 (NN)-based ceramics have attracted a lot of interests for energy-storage capaci-

tors.^{7,13,14,18,19} Pure NN ceramic exhibits an AFE orthorhombic P phase ($Pbma$ space group) at room temperature and transforms into an AFE orthorhombic R phase ($Pnma$ space group) at about $360\ ^\circ\text{C}$ on heating.²⁰ However, because of the electric-field-induced irreversible AFE to FE phase transition,^{21,22} pure NN ceramics should display poor energy-storage properties at room temperature, as shown in Figure 1a. Recent studies demonstrated that repeatable double P - E loops can be obtained in both P ^{21,23} and R ⁷ phase after the addition of some ABO_3 perovskites, which should increase the application potentials of NN-based AFEs in energy-storage capacitors. For example, CaZrO_3 was reported to stabilize the AFE P phase with improved W_{rec} of $\sim 0.55\ \text{J}/\text{cm}^3$ and η of

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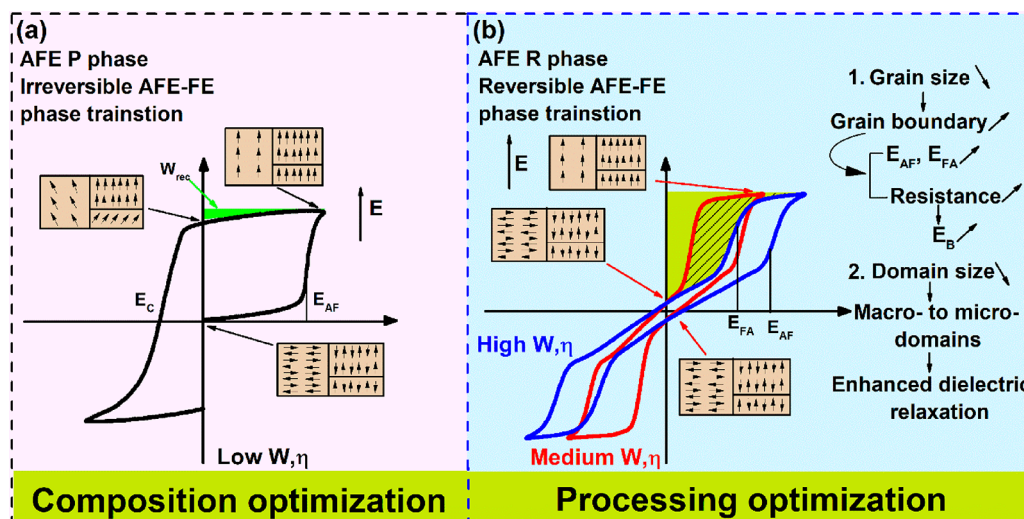


Figure 1. Schematic diagram of W_{rec} in NN-based AFE (a) P-phase and (b) R-phase ceramics by means of composition and processing optimization.

63%,²² whereas $(\text{Bi}_{0.5}\text{Na}_{0.5})\text{TiO}_3$ was reported to induce the AFE R phase at room temperature with high energy-storage performances (W_{rec} of $\sim 12.2 \text{ J/cm}^3$ and η of 69%).⁷ Compared with the AFE P phase, the AFE R-phase NN-based ceramics have relatively low-hysteresis P - E loops,⁷ meaning relatively large potentials in energy-storage properties. In addition to the composition design, the effect of processing optimization on the energy-storage performance of NN-based AFE ceramics has been rarely investigated until now.

Besides the perovskite additives, the phase stability of AFE ceramics can also be affected by processing,^{24–26} as indicated in Figure 1b. On the one hand, the reduction of grain size tends to enhance the stability of the AFE phase, thus affecting the critical electric field for AFE-FE (E_{AF}) and FE-AFE (E_{FA}) phase transition.^{26,27} Furthermore, the change of grain size proves to be closely related with the E_{B} value, generally showing a reciprocal relation between them.^{28,29} This should be basically ascribed to the high resistivity of grain boundary.³⁰ As a consequence, changing sintering atmosphere,³¹ introducing dopants²⁷ and adopting some special sintering methods (including spark plasma sintering,^{32,33} microwave sintering,^{34,35} liquid phase sintering,^{36,37} and two-step sintering^{29,38} have been used to densify the ceramic body simultaneously with desirable microstructure. On the other hand, the processing of the ceramic also exhibits an obvious influence on dielectric properties, particularly inducing obvious dielectric relaxation behavior.^{39–41} Because of the local composition inhomogeneity, which induces the formation of relaxor characteristics in FE or AFE ceramics proves to be efficient in adjusting domain switching, phase transition, and energy-storage properties.^{7,42–45}

The $(1-x)\text{NN}-x\text{SrTiO}_3$ ($(1-x)\text{NN}-x\text{ST}$) binary system has been systematically investigated in terms of local and average structure evolutions, and exhibits an AFE orthorhombic R phase at room temperature at $x > 0.14$ and excellent energy-storage properties at $x = 0.20$ ($W_{\text{rec}} \approx 3.02 \text{ J/cm}^3$ @ 31 kV/mm).^{46,47} Repeatable slim and double P - E loops as well as large polarization difference make NN-ST R-phase ceramics a competitive lead-free AFE candidate for energy-storage application. However, E_{AF} is not high enough compared with

some other NN-based AFEs and the E_{B} also needs to be improved. In this work, the 0.83NN-0.17ST AFE ceramic was chosen as a case composition and densified by a two-step sintering method to demonstrate how the energy-storage properties can be correlated with the adjustment of microstructure of different scales. A series of well-dense AFE ceramic samples with large spans of average grain size were obtained by varying sintering parameters, aiming at exploring their energy-storage characteristics and relevant physical mechanisms. The results demonstrate a giant amplification by 176% of the energy-storage density W_{rec} in the processing modulated AFE ceramic, which was attributed to the dual adjustment of local inhomogeneity and grain scale by means of dielectric permittivity versus temperature and frequency spectra, Raman spectra, and quantitative analysis of grain size.

2. EXPERIMENTAL SECTION

The 0.83NN-0.17ST ceramics were prepared via a solid-state reaction method by using high-purity (>99%) Na_2CO_3 , Nb_2O_5 , SrCO_3 , and TiO_2 as raw materials. The powders were mixed thoroughly in ethanol using zirconia balls for 10 h according to their compositional formula. The mixture was ball-milled again for 10 h after calcination at 900 °C for 5 h. The sample compacts were densified by a two-step sintering. The samples were first heated at 5 °C/min to T_1 , then cooled at 10 °C/min to T_2 and held at T_2 for 2–4 h, as shown in Table 1.

The crystal structure was examined by an X-ray diffractometer (XRD, D/Max-RB, Rigaku, Tokyo, Japan) using $\text{Cu K}\alpha$ radiation. To quantitatively describe the phase structure, we analyzed the XRD data by the Rietveld refinement using GSAS software. The microstructure

Table 1. Sintering Parameters, Relative Densities and Average Grain Sizes of 0.83NN-0.17ST Ceramics Achieved by Two-Step Sintering

sintering temperature (T_1/T_2) (°C)	holding time (h)	relative density (%)	average grain size (μm)	sample no.
1350/1280	2	95	1.2	S1
1350/1280	4	96	2.7	S2
1350/1300	2	96	3.4	S3
1350/1300	4	97	4.9	S4
1400/1300	2	98	6.5	S5
1400/1300	4	98	8.2	S6

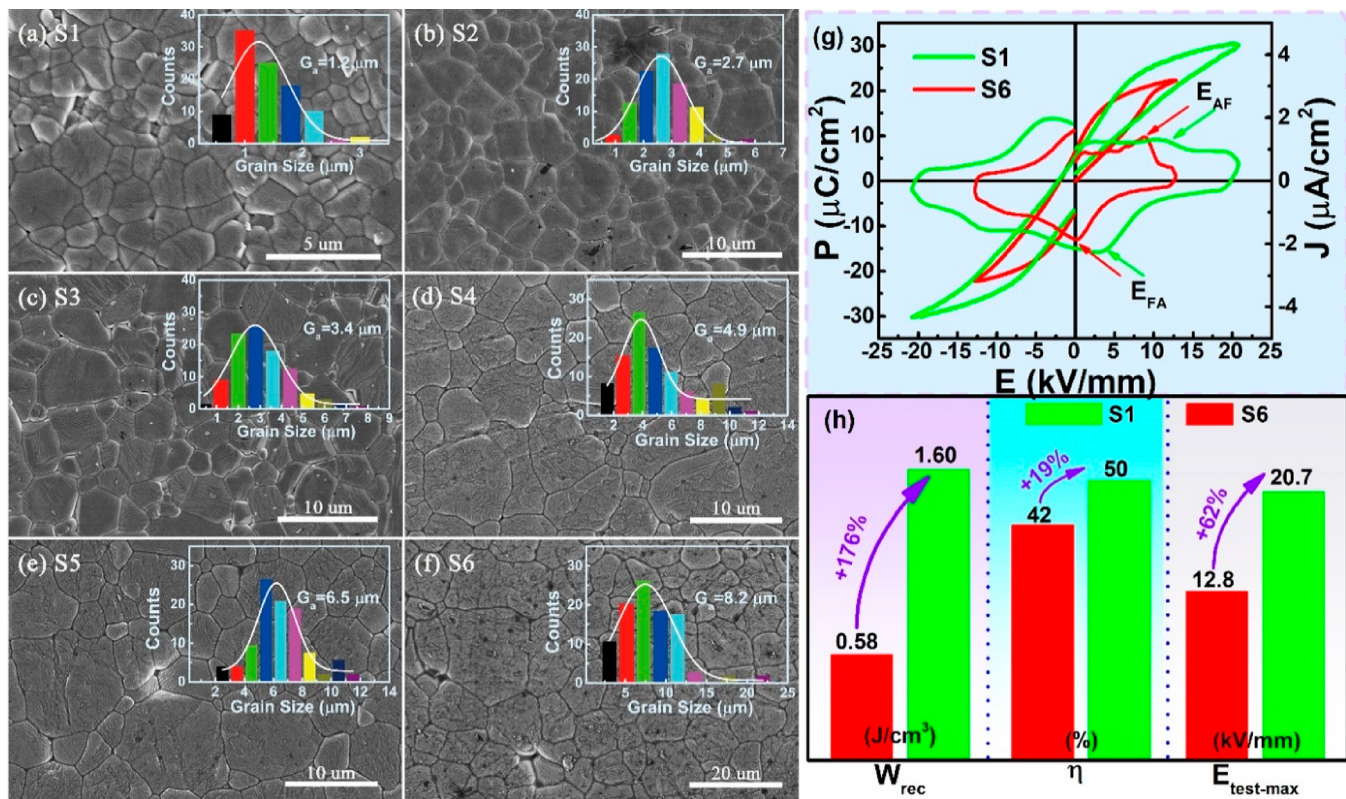


Figure 2. (a–f) SEM images on the polished and thermally etched surfaces of 0.83NN-0.17ST ceramics by two-step sintering. Samples are numbered as S1–S6 in the sequence of the increase of the average grain size (G_a). (g) P - E loops and the corresponding J - E curves for S1 and S6 samples measured under their maximum testable electric fields at 10 Hz; (h) a comparison of W_{rec} and $E_{test-max}$ between S1 and S6 samples.

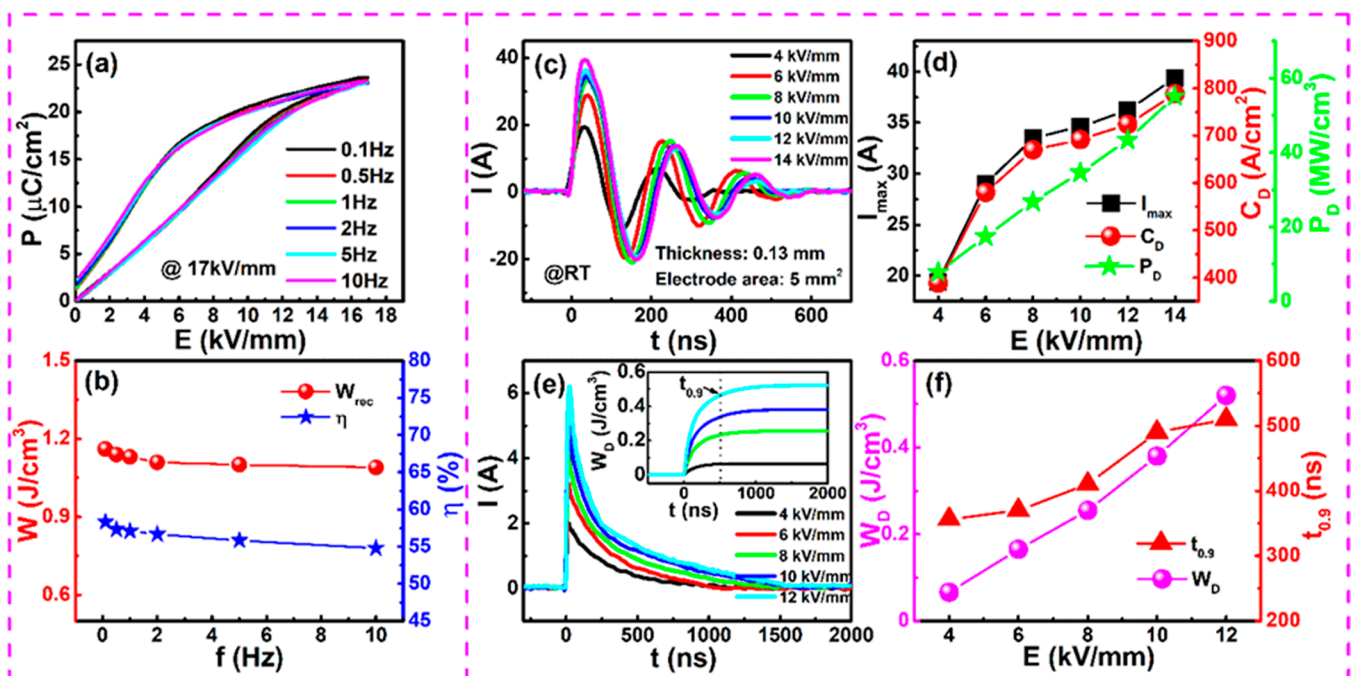


Figure 3. (a) P - E loops of the S1 sample measured at room temperature in the frequency range of 0.1–10 Hz; (b) W_{rec} and η values as a function of frequency; (c) room-temperature pulsed underdamped discharging current curves of the S1 sample under various electric fields; (d) variation in I_{max} , C_D , and P_D with the applied electric field; (e) room-temperature pulsed overdamped discharging current curves of the S1 sample at a fixed load resistance of 300 Ω under various electric fields; and (f) W_D and $t_{0.9}$ values as a function of the applied electric field for the S1 sample. The inset of e shows the W_D - t curves under different electric fields.

of the ceramic specimens was observed by a field-emission scanning electron microscope (FE-SEM, SU8020, JEOL, Tokyo, Japan). Before

the SEM observation, the samples were polished and thermally etched at ~ 1150 $^{\circ}\text{C}$ for 20 min. The dielectric properties at various

temperatures and frequencies were measured using a broad frequency dielectric spectrometer (Concept 80, Novocontrol Inc., Germany) at a heating rate of 3 °C/min. Impedance spectroscopy was measured using a precise impedance analyzer (4294A, Agilent Technologies, Santa Clara, CA, USA). The E_B measurement was performed at room temperature by using a voltage-withstand test device (BDJC-50KV, Beiguangjingyi Instrument Equipment Co. Ltd., Beijing, China). Raman spectra were collected on well-polished samples by 532 nm laser excitation using a Raman spectrometer (LabRam HR Evolution, HORIBA JOBIN YVON, Longjumeau Cedex, France). The P – E hysteresis loops were measured by using an FE measuring system (Precision multiferroelectric, Radiant Technologies Inc., Albuquerque, NM) and the sample size is 0.13 mm (thickness) \times 5 mm² (electrode area). The energy release characteristics of ceramic capacitors were investigated by a charge–discharge platform (CFD-001, Gogo Instruments Technology, Shanghai, China) with a certain discharge resistance, inductance, and capacitance load circuit (RLC).

3. RESULTS AND DISCUSSION

The SEM micrographs of the as-sintered 0.83NN-0.17ST ceramic samples are presented in Figure 2a–f. Samples are numbered as S1–S6 according to the increase of grain size, which were achieved by varying two-step sintering parameters. It can be seen from Figure 2 and Table 1 that all samples have been well densified with a high relative density of $\geq 95\%$, indicating little influence of the sample density on the AFE phase stability.⁴⁸ The grain size distribution of different ceramic samples were analyzed according to the fitting by Gauss function, as shown in the insets of Figure 2a–f and Table 1. The change in sintering parameters has resulted in the preparation of well-densified ceramic samples having a wide average grain size range from ~ 1.2 to ~ 8.2 μm . The suppression of grain growth was mainly ascribed to the lack of grain boundary migration but the validity of grain boundary diffusion or bulk diffusion through selecting appropriate holding temperatures (T_2) during two-step sintering.⁴⁹

Figure 2g shows the P – E loops and the corresponding polarization current density–electric field (J – E) curves for S1 and S6 samples with smallest and largest average grain size under their maximum testable electric fields ($E_{\text{test-max}}$), respectively. An obviously slim P – E loop can be obtained on both samples, but the S1 sample have a much larger $E_{\text{test-max}}$ than the S6 sample (Figure 2h, increase by $\sim 62\%$), meaning that the former with smaller grain size probably owns a larger E_B value. As indicated in Figure 2h, the W_{rec} value of the fine-grain S1 sample can be increased by 176% as compared with that of the coarse-grain S6 sample, which approximates to 1.60 J cm^{−3} and 0.58 J cm^{−3}, respectively. At the same, the η value was enhanced by 19%.

Furthermore, P – E loops measured under different frequencies for the S1 ceramic are further shown in Figure 3a. It can be seen that P – E loops exhibit a weak frequency dependence in the measured frequency range. The AFE-FE phase transition and the domain wall motion lag as the measurement frequency increases, leading to an increase in E_{AF} but a decrease in E_{FA} . A small reduction in P_{max} with increasing frequency mainly comes from the time effect of field induced FE polarization response as the applied electric field is larger than E_{AF} . As a result, both W_{rec} and η values decrease slightly from ~ 1.16 J/cm³ and ~ 58 to ~ 1.09 J/cm³ and $\sim 55\%$ with increasing frequency from 0.1 to 10 Hz, respectively, as shown in Figure 3b.

Pulsed charging–discharging measurement was used to evaluate the actual energy-storage performance of the ceramic capacitor. Figure 3c illustrates the electric-field-dependent

underdamped pulsed discharge electric current–time (I – t) curves for the S1 ceramic at room temperature. The stored charge was found to be released rapidly (≤ 600 ns) under different electric fields. The variation of the first current peak amplitude (I_{max}), current density ($C_D = I_{\text{max}}/S$) and power density ($P_D = EI_{\text{max}}/2S$; S denotes the electrode area of the sample and E is the electric field strength) as a function of the applied electric field can be obtained from the I – t curves of the S1 ceramic, as shown in Figure 3d. The value of I_{max} increases from 19.5 A at 4 kV/mm to 40 A at 14 kV/mm. Moreover, the corresponding C_D and P_D at 14 kV/mm reach their maximum values of 788 A/cm² and 55 MW/cm³, respectively. The high values of C_D and P_D indicate that the S1 sample is superior to some other reported dielectric ceramics,^{18,19,50–52} as compared in Table 2, hopefully becoming potential candidates for the application in pulsed power capacitors.

Table 2. Comparison of Charge–Discharge Properties between the S1 Sample and Some Other Promising Energy-Storage Dielectric Ceramics

composition	E (kV/mm)	C_D (A/cm ²)	P_D (MW/cm ³)	$t_{0.9}$ (ns)	ref
PLZST	4	447	8.94		50
PLBZST	6.67	242	8	~ 1000	51
BT-BNZ	6		6.15	~ 1706	52
NN-BMNN	10	382	19		18
NN-BZT	12	642	38	~ 50	19
This work	14	788	55	~ 500	

^aThe following abbreviations are used: PLZST, $\text{Pb}_{0.94}\text{La}_{0.04}(\text{Zr}_{0.4704}\text{Sn}_{0.3696}\text{Ti}_{0.16})\text{O}_3$; PLBZST, $\text{Pb}_{0.90}\text{La}_{0.04}\text{Ba}_{0.04}[(\text{Zr}_{0.7}\text{Sn}_{0.3})_{0.88}\text{Ti}_{0.12}]\text{O}_3$; BT-BNZ, $0.90\text{BaTiO}_3\text{-}0.10\text{Bi}(\text{Zn}_{0.5}\text{Zr}_{0.5})\text{O}_3$; NN-BMNN, $0.85\text{NaNbO}_3\text{-}0.15\text{Bi}(\text{Mg}_{2/3}\text{Nb}_{1/3})\text{-NbO}_3$; NN-BZT, $0.91\text{NaNbO}_3\text{-}0.09\text{Bi}(\text{Zn}_{0.5}\text{Ti}_{0.5})\text{O}_3$.

Overdamped discharge curves as a function of electric field are shown in Figure 3e. According to the overdamped discharge curves, the discharge energy density under different electric fields ($W_D = R \int I(t)^2 dt/V$, where V is the sample volume and R is the total load resistor of 300 Ω) can be obtained, as shown in the inset of Figure 3e. The current peak (I_{max}) and W_D values increase with increasing electric field, from 2 A and 0.07 J/cm³ at 4 kV/mm to 6.2 A and 0.52 J/cm³ at 12 kV/mm, respectively. The discharge rate can be estimated by discharge time ($t_{0.9}$), which describes the time just corresponding to reaching 90% saturated W_D value. Under a relatively low electric field of ~ 4 kV/mm, the S1 ceramic sample shows a fast discharge rate with a short $t_{0.9} \approx 350$ ns owing to little contribution from the AFE-FE phase transition. $t_{0.9}$ increases with increasing electric field because of a gradual increase of the contribution of the AFE domain reorientation and the AFE-FE phase transition, both of which show much slower response to external electric field than the domain wall vibration/motion in the lower electric field range than E_{AF} . Nevertheless, a short $t_{0.9}$ of < 520 ns can be found for the S1 sample in the studied electric field range.

Although the significant improvement of energy-storage properties from S6 to S1 samples seems to be ascribed to the obviously enhanced applicable electric field magnitudes (Figure 2h), the fundamental physical mechanism still needs to be clarified by means of multiscale characterization. Figure 4a,b show P – E hysteresis loops and the corresponding J – E curves of 0.83NN-0.17ST ceramics under the same electric

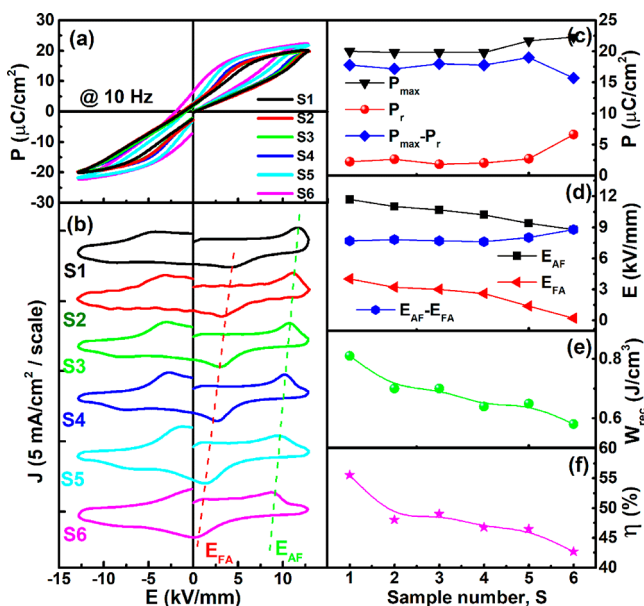


Figure 4. (a) P - E hysteresis loops and (b) the corresponding J - E curves for 0.83NN-0.17ST ceramics with different grain sizes at room temperature. The evolution of (c) P_{\max} , P_r , and $P_{\max}-P_r$; (d) E_{AF} , E_{FA} and $E_{AF}-E_{FA}$; (e) W_{rec} ; and (f) η values of different samples from S1 to S6.

field. Double-like P - E loops as well as double current peaks can be observed in all the studied samples, indicating typical AFE behavior. The evolution of P_{\max} , P_r , $P_{\max}-P_r$, E_{AF} , E_{FA} , and $E_{AF}-E_{FA}$ with changing grain size is shown Figure 4c, d. Both P_{\max} and P_r decrease slightly with decreasing average grain size, because of the increased pinning effect of grain boundary on domain switching and the reduced phase switching hysteresis for stabilized AFE phases,^{26,27} respectively. A large $P_{\max}-P_r$ value of over $15 \mu\text{C}/\text{cm}^2$ can be obtained in the studied ceramic samples. As grain size decreases, both E_{AF} and E_{FA} values increase, probably because of the decrease and increase in the effective electric field on grains and grain boundaries, respectively. The increase in grain boundary content would lead to the increase of grain boundary resistance which causes the grain boundaries to share more electric fields. Large $P_{\max}-P_r$ and increased E_{AF} are responsible for the enhanced W_{rec} of the 0.83NN-0.17ST samples with decreasing grain size, as shown in Figure 4e. Most importantly, it can be seen that the difference value between E_{AF} and E_{FA} ($E_{AF}-E_{FA}$), which is an important parameter to evaluate the hysteresis of the AFE-FE phase transition, decreases slightly with decreasing grain size, thus leading to the enhancement of the energy-storage efficiency η , as shown in Figure 4f. This may be ascribed to the increase of internal stress between grains as grain size decreases.^{27,53} Nevertheless, grain size engineered AFE ceramics were found to achieve largely tunable energy-storage properties through changing AFE-FE and FE-AFE phase transition, and AFE and FE domain switching process based on typical boundary effects.

Figure 5a,b show permittivity versus temperature and frequency curves and Raman spectra of S1-S6 ceramic samples, respectively. It can be found that the dielectric relaxation degree obviously increases from S6 to S1 samples, as characterized by the increase of the relaxation factor ΔT_{relax} ($=T_{m,1 \text{ MHz}} - T_{m,1 \text{ kHz}}$) and the diffuseness degree γ , and the decrease of the temperature at the maximum dielectric

permittivity (T_m) (see the inset of Figure 5a). The appearance of dielectric relaxor behavior is usually related to the enhanced random (electric or strain) fields due to the local composition disorder,^{54,55} as characterized by Raman spectra shown in Figure 5b. The coarse-grain S6 sample exhibits obviously split multiplexes in the wavenumber range of 100 - 300 cm^{-1} , which mainly correspond to the bending modes of the NbO_6 octahedra as a result of the antiparallel off-centering displacement of B-site cations. By comparison, the Raman peaks become obviously broadening and blurry from S6 to S1 samples, thus leading to a nearly smooth Raman spectrum for the S1 sample. According to the deconvolution results, little change in the number of Raman peaks suggests the unchanged local symmetry. However, evidently increased full width at half-maximum (fwhm) and decreased peak intensity for both ν_5 and ν_1 vibration modes suggest the increase of structural disorder and the decrease of the unit cell polarity, as shown in Figure 5c, d where the intensity and fwhm for typical ν_5 and the ν_1 modes are mainly related to the vibration of the B-O bond and the BO_6 octahedra tilting configuration, respectively. The formation of the local heterogeneity might be related to insufficient mass transfer as a result of little holding time at high-temperature T_1 during two-step sintering. The resulting local random fields would influence the phase switching between AFE and FE in response to external electric fields. In comparison with normal AFEs, the existence of larger local random fields in relaxor AFEs can effectively impede the growth of nanodomains and the subsequent phase transition process,⁷ leading to higher E_{AF} . Simultaneously, the larger local random fields also provide a restoring force, which makes the back-switching process of FE to AFE easier, producing higher E_{FA} and lower hysteresis as well, as shown in Figure 4d.

As known, impedance spectroscopy is a powerful tool to investigate electrical conduction and dielectric relaxation mechanism. Figure 6a shows the Z' - Z'' curves for S1-S6 samples measured at $425 \text{ }^\circ\text{C}$ in the frequency range of 20 Hz to 1 MHz. Z' and Z'' are the real and imaginary parts of impedance, respectively. It can be seen that all of the studied samples exhibit a nearly single impedance arc. However, these arcs are unable to be fitted by an RC equivalent circuit, indicating the existence of contributions from both grains and grain boundaries.⁵⁶ In order to distinguish the respective contribution of grains and grain boundaries, it is necessary to construct an equivalent analog circuit for fitting, as shown in the inset of Figure 6a. This circuit is composed of a series of grain and grain boundary components, including grain resistance (R_g), grain capacitance (C_g), grain boundary resistance (R_{gb}), and grain boundary capacitance (C_{gb}). A good agreement between the fitted lines and the tested results indicates that the adopted fitting circuit is equivalent to the experimental results. Figure 6b shows the quantitative relationship between grain resistivity (ρ_g), grain boundary resistivity (ρ_{gb}) and total resistivity (ρ_{total}) of each sample at $425 \text{ }^\circ\text{C}$. It can be found that the main contribution to the macroscopic resistivity comes from grain boundary for each sample. ρ_{gb} obviously increases with decreasing grain size from S6 to S1 due to the increased fraction of grain boundary.^{56,57} The slightly increased ρ_g with decreasing grain size should be ascribed to the decrease of oxygen vacancies and defects probably as a result of the reduction of the volatilization of sodium caused by improved sintering processes. Figure 6c shows the Z''/Z'_{max} as a function of frequency for the S1 ceramic in the temperature range of 400 - $500 \text{ }^\circ\text{C}$. Only one

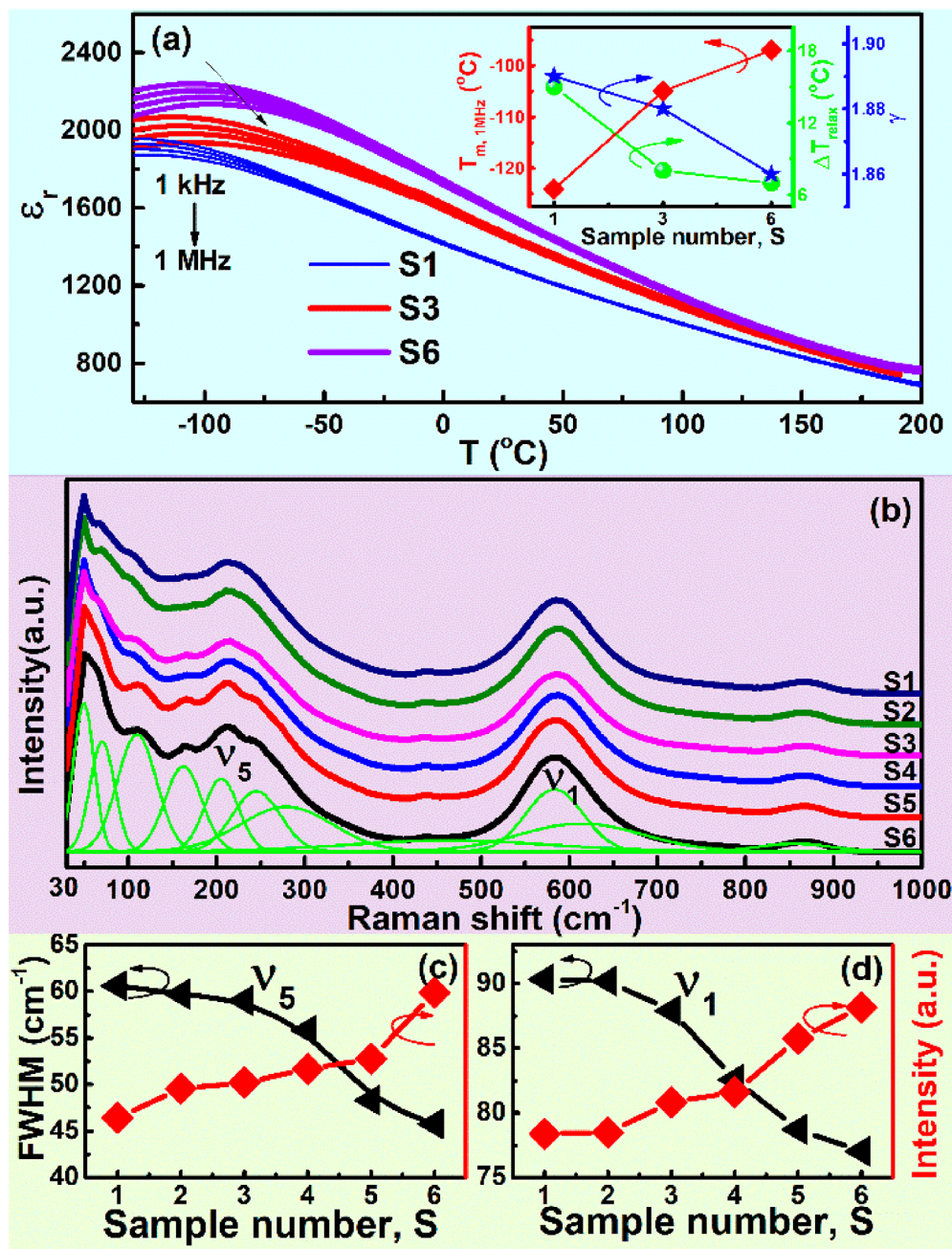


Figure 5. (a) Dielectric permittivity of S1, S3, and S6 samples as a function of temperature and frequency measured on heating; (b) room-temperature Raman spectra of S1–S6 samples; variation in peak intensity and fwhm of (c) ν_5 and (d) ν_1 Raman vibration modes. The inset of a shows the values of ΔT_{relax} , γ , and T_m as a function of sample number.

peak can be observed, which shifts toward higher frequency with increasing temperature, indicating that the temperature-dependent relaxation behavior is mainly caused by defects or vacancies in the ceramic. Moreover, the activation energy of the conductivity can be calculated by the Arrhenius equation:⁵⁸

$$\sigma = \sigma_0 \exp(E_a/kT) \quad (1)$$

where σ ($= 1/\rho$, where ρ is resistivity) is the bulk conductivity, σ_0 is the pre-exponent constant, E_a is the activation energy of conduction, and k is the Boltzmann constant. E_a can be calculated from the slope of $\ln \sigma - 1000/T$ plots, as shown in the inset of Figure 6d using the linear fitting results of the S1 ceramic as an example. It has been reported that the activation energies of single ionized oxygen vacancies and double ionized

oxygen vacancies are in the range of 0.3–0.5 eV and 0.6–2 eV,^{59,60} respectively. The activation energies of grain and grain boundary are both in the range of 0.67–1.76 eV for S1–S6 ceramics, as shown in Figure 6d, demonstrating that they are mainly caused by double ionized oxygen vacancies. Moreover, E_a values for both grain and grain boundary increase with decreasing grain size, bringing about higher potential barriers for the diffusion of oxygen vacancies. The enhanced resistivity and the increased steadiness of oxygen vacancies with decreasing grain size should be also beneficial for the improved E_B .

The E_B value can be experimentally evaluated through the Weibull distribution using the following equations:⁶¹

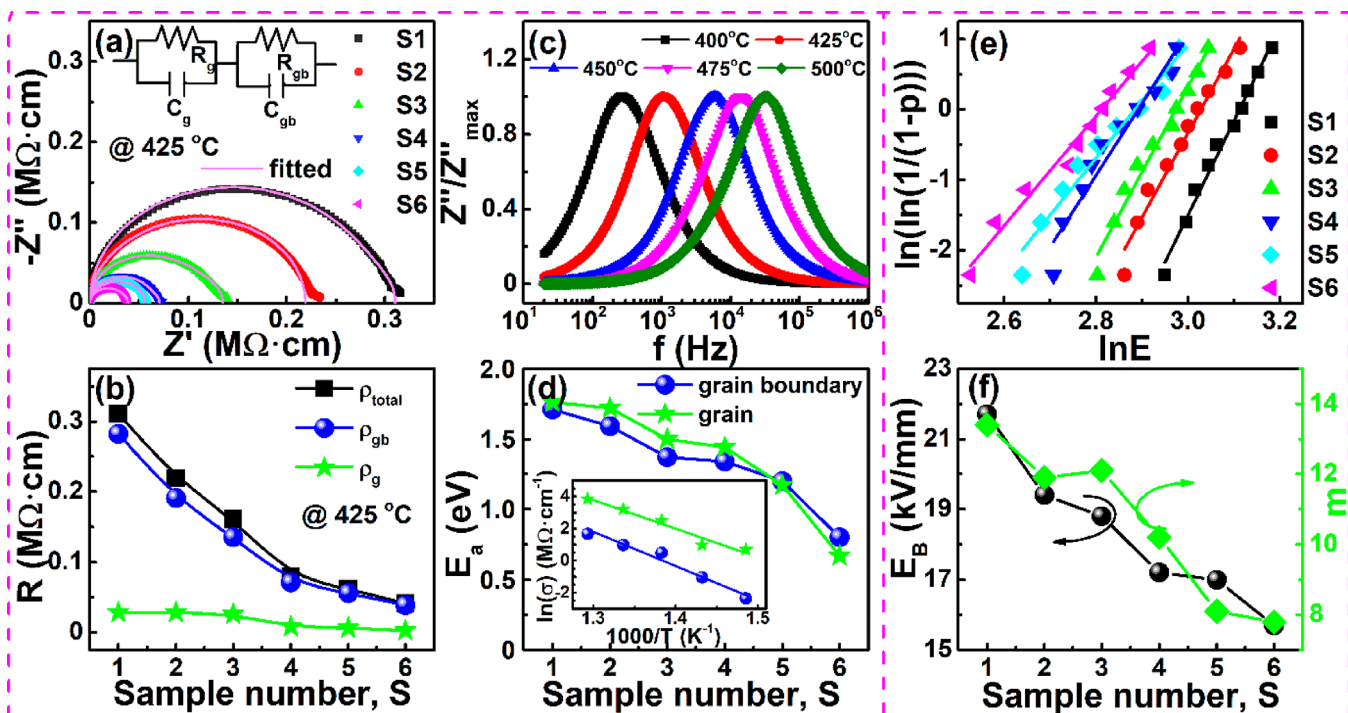


Figure 6. (a) Complex AC impedance and fitting semicircles at 425 °C for the S1–S6 samples, (b) the values of ρ_{total} , ρ_{gb} , and ρ_{g} obtained from the fitting results, (c) plots of Z''/Z''_{max} versus frequency in the temperature range of 400–500 °C for the S1 ceramic, (d) the variation in the activation energy (E_a) of grain and grain boundary conductivity for the S1–S6 ceramics. The inset of (d) is the Arrhenius-type plots of bulk conductivity of the grain and grain boundary for the S1 ceramic. (e) Weibull distributions and fitting lines of the breakdown strength E_B , and the determined E_B and the Weibull modulus m of the S1–S6 ceramics.

$$X_i = \ln(E_i) \quad (2)$$

$$Y_i = \ln\{\ln[1/(1 - i/n + 1)]\} \quad (3)$$

where n is the sum of all samples, E_i is the breakdown electric field for each sample, and i is the serial number of samples. The samples are arranged in ascending order so that $E_1 \leq E_2 \leq \dots \leq E_n$. The value of E_B can be evaluated by the Weibull distribution through a linear fitting between X_i and Y_i . The slope of the line (shape parameter m) is related to the range of the E_B , whereas the intercept on the x -axis is related to the magnitude of the E_B . The fitting results are displayed in Figure 6e, f. The shape parameter m of all compositions is larger than 7, proving high reliability of the obtained E_B values. It is obvious that all data fit well with the Weibull distribution with good linear relationship between X_i and Y_i . It can be found that the average E_B increases monotonously with decreasing grain size in the studied grain size range. As a result, the E_B value usually has an exponential decay relationship with average grain size (G_a), i.e., $E_B \propto (G_a)^{-d}$ on the basis of high relative density.²⁸ Actually, because of the increased local composition disorder, the vague polarization current peak caused by sluggish switching process should also help improve the dielectric breakdown behavior.

4. CONCLUSIONS

Recoverable energy-storage density can be remarkably amplified in two-step sintered 0.83NN-0.17ST lead-free relaxor AFE R-phase ceramics by means of dual adjustment of local heterogeneity and grain scale. Obviously enhanced dielectric relaxation behavior and significantly refined grain morphology synergistically contribute to energy-storage properties from

different structure scales through optimizing the phase switching process between AFE and FE phases and increasing the effective dielectric breakdown strength E_B . As a result, the S1 sample with average grain size $\sim 1.2 \mu\text{m}$ has a W_{rec} of $\sim 1.60 \text{ J/cm}^3$, which is about 2.76 times of the W_{rec} value for the S6 sample with average grain size $\sim 8.2 \mu\text{m}$. Moreover, the fine-grain S1 sample also exhibits a fast discharge time ($\leq 520 \text{ ns}$), large current density (788 A/cm^2), and large power density (55 MW/cm^3), illustrating great potentials for high-power pulsed capacitor applications.

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Notes

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